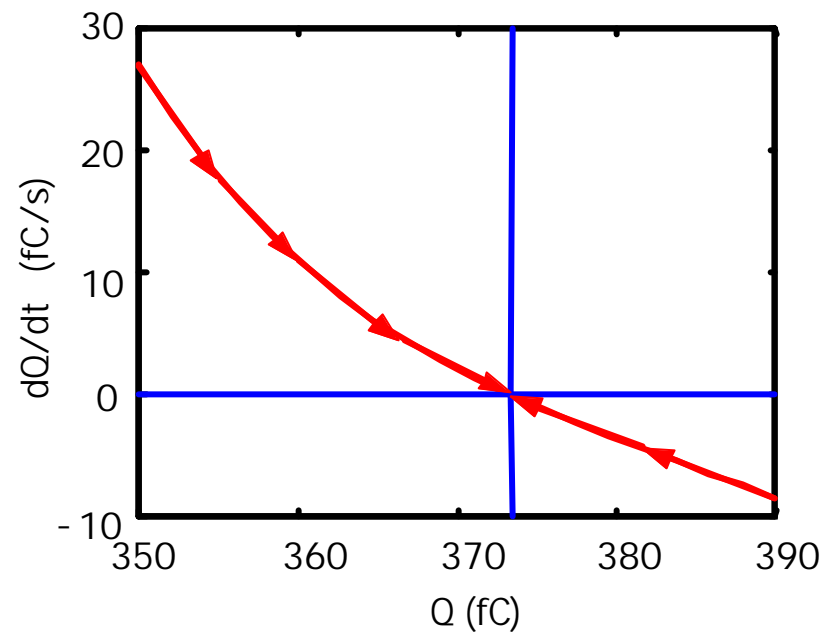
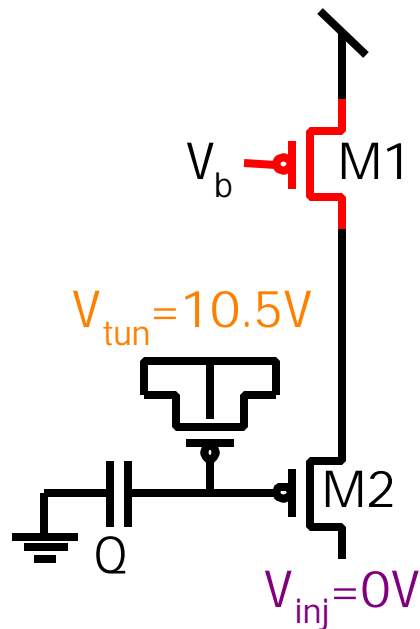


Examples of storing a weight

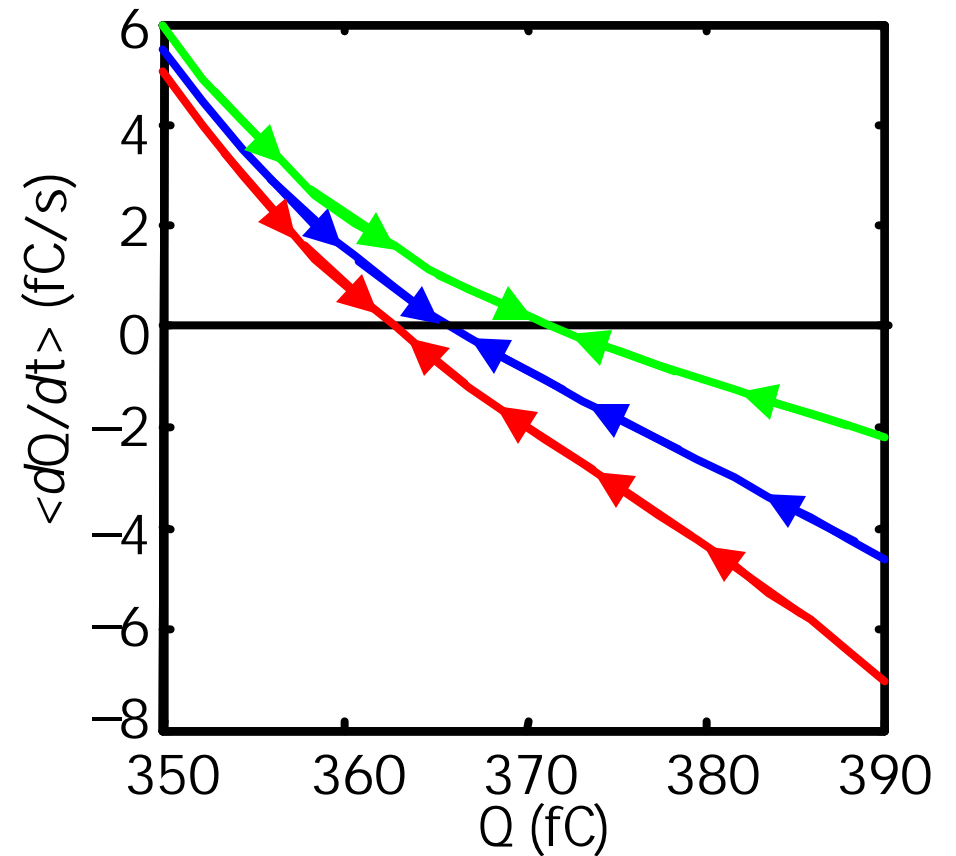
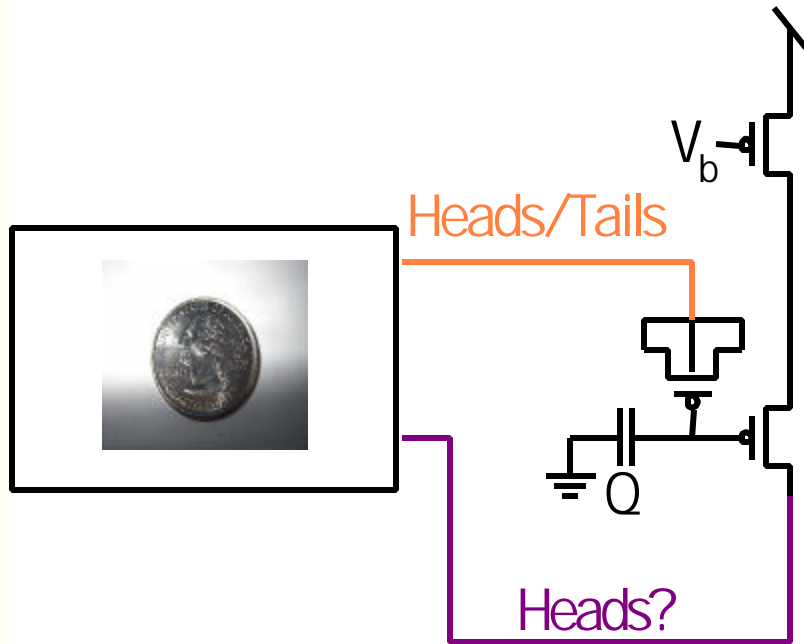
- As charge
- As current
 - storing a given current
 - spike-based incremental update with $\Delta W = \text{func}(W)$
- Storing a voltage
 - incremental update with ΔW independent of W
 - E-pots

Storing weight as charge

- Charge Q encodes state of system
- Weight set by competition between tunneling and injection (tunneling increases charge, injection decreases charge)



Coin flipping



Q encodes the coin's bias

from work by David Hsu

Spike-based equilibrium point

- Equilibrium weight $\left\langle \frac{dQ}{dt} \right\rangle = 0$
- Function of statistics of spike inputs V_{tun} and V_{inj}

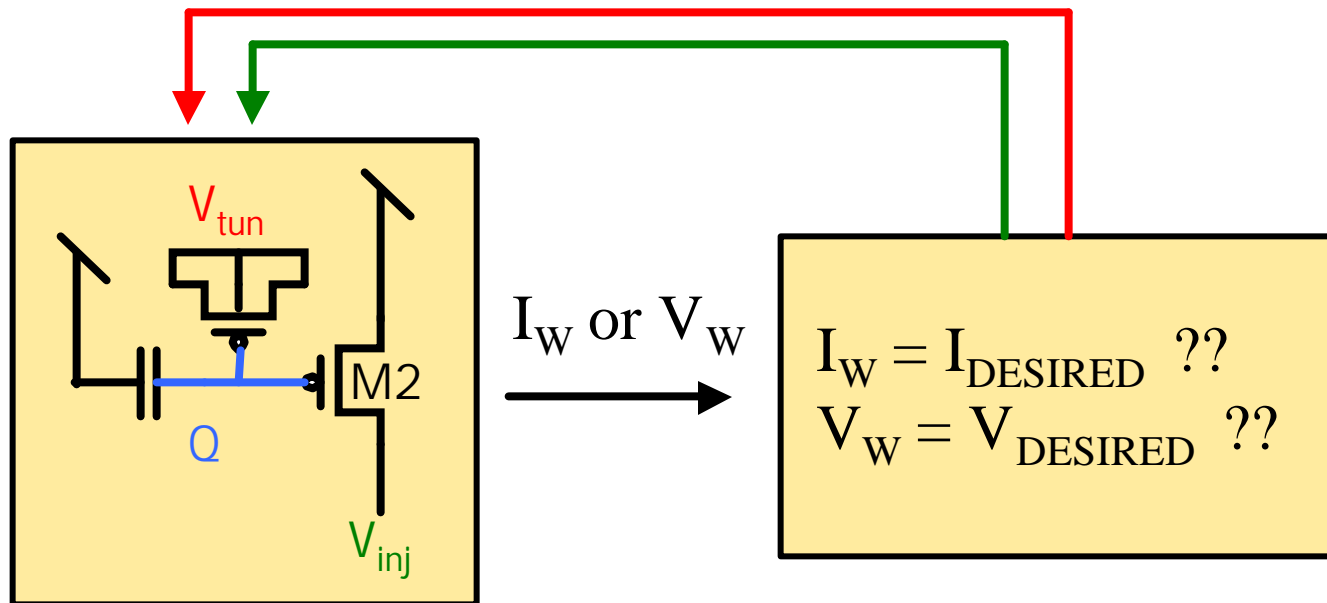
$$Q_{eq} = \left(\frac{P(\neg V_{inj})}{P(V_{tun})} \right)^{\frac{1}{b+c}}$$

- Circuit learns power-law probability ratio
- V_{inj} and V_{tun} can be controlled by arbitrary logic functions
- **Problems:**
 - cannot read out Q directly
 - mismatch between tun & inj

Using feedback

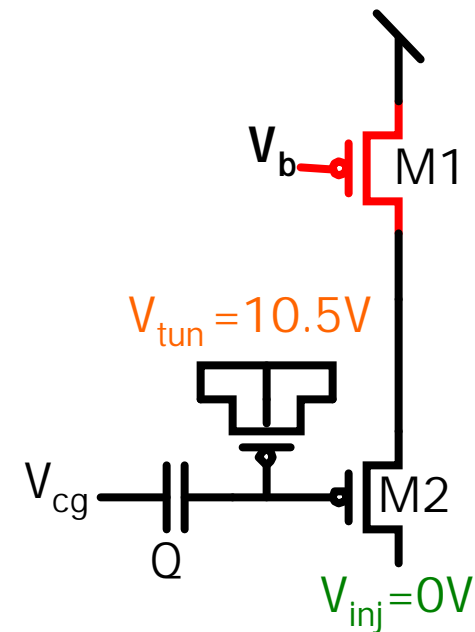
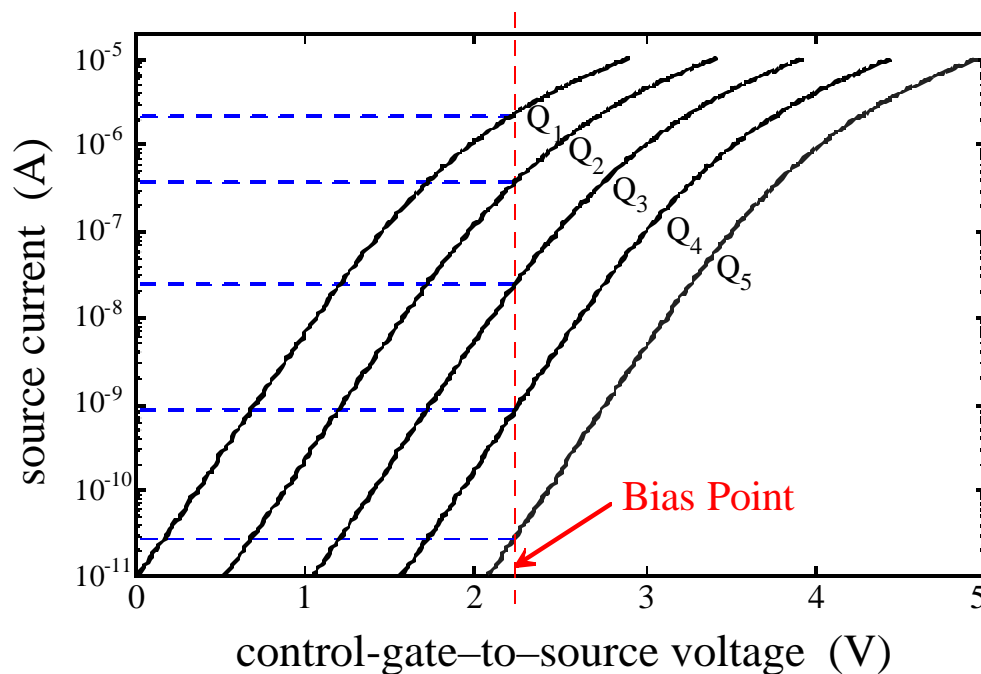
Since:

1. I_{TUN} and I_{INJ} are exponential
 2. I_{TUN} and I_{INJ} are poorly matched
- one option is to use feedback when storing a weight.



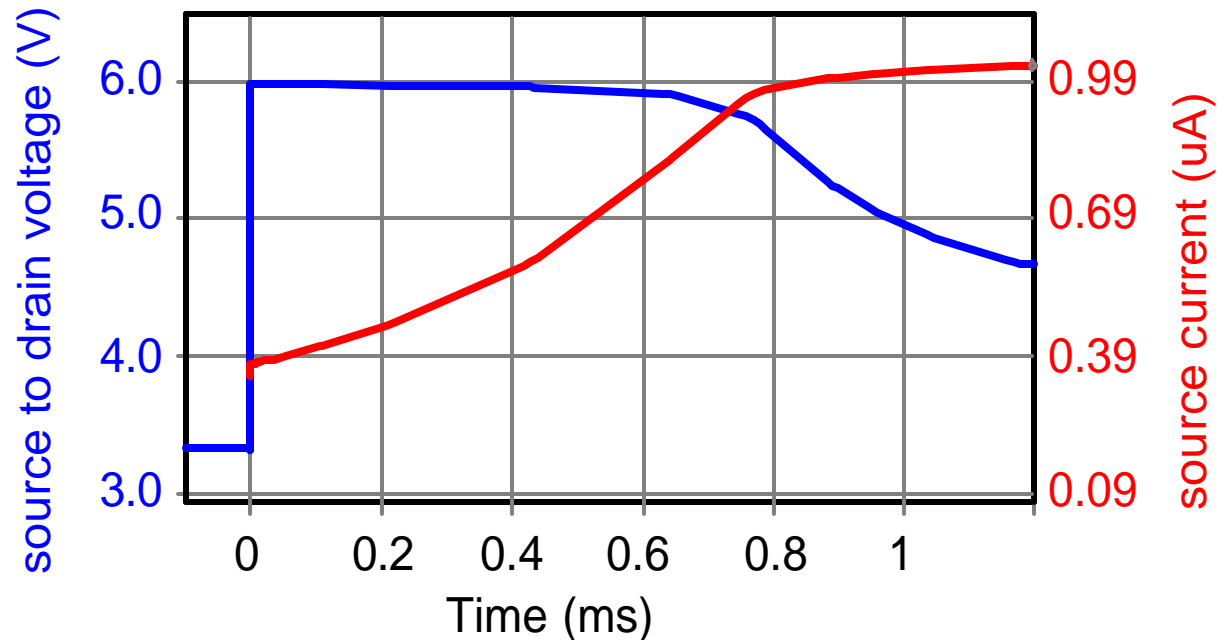
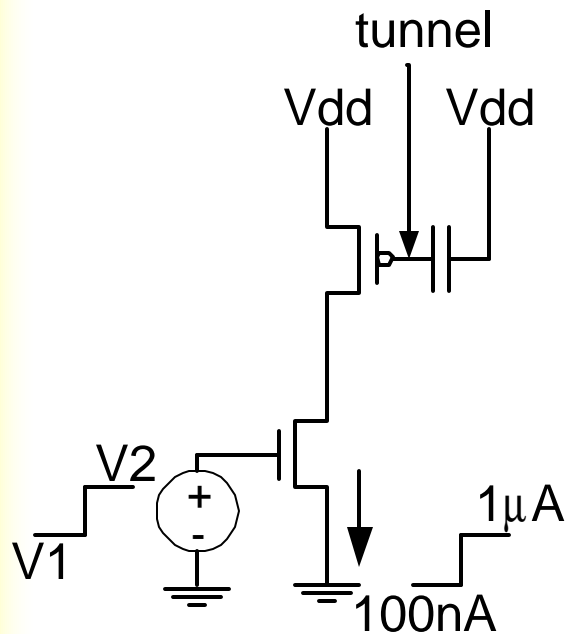
Storing weight as current

- Charge on floating gate shifts pFET transfer function
 - increase charge by electron tunneling (curve shifts right)
 - decrease charge by electron injection (curve shifts left)



Self-convergent programming

- Weight stored as current
- Current to be stored is input; then can be disconnected.
- Use tunneling to erase weight, injection to write



$$I_{out} = \text{Weight} * I_{baseline}$$

General transistor current equation:

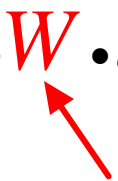
$$I_{ds} = \frac{W}{L} * I_o * e^{\frac{k * V_g}{U_t}}$$

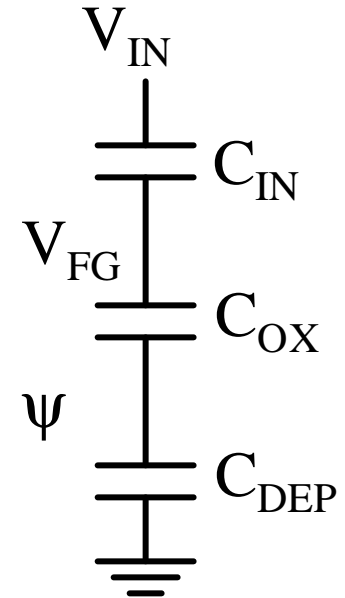
Floating gate voltage:

$$V_{FG} = \frac{Q_{FG}}{C_T} + \frac{C_{IN} V_{IN}}{C_T}$$

Floating gate transistor equation:

$$I_{ds} = \frac{W}{L} \cdot I_o \cdot e^{\left[\frac{k(Q_{FG} + C_{IN} V_{IN})}{C_T \cdot U_t} \right]} = \frac{W}{L} \cdot I_o \cdot \mathbf{W} \cdot e^{\left[\frac{k V_{IN}}{U_t} \right]}$$



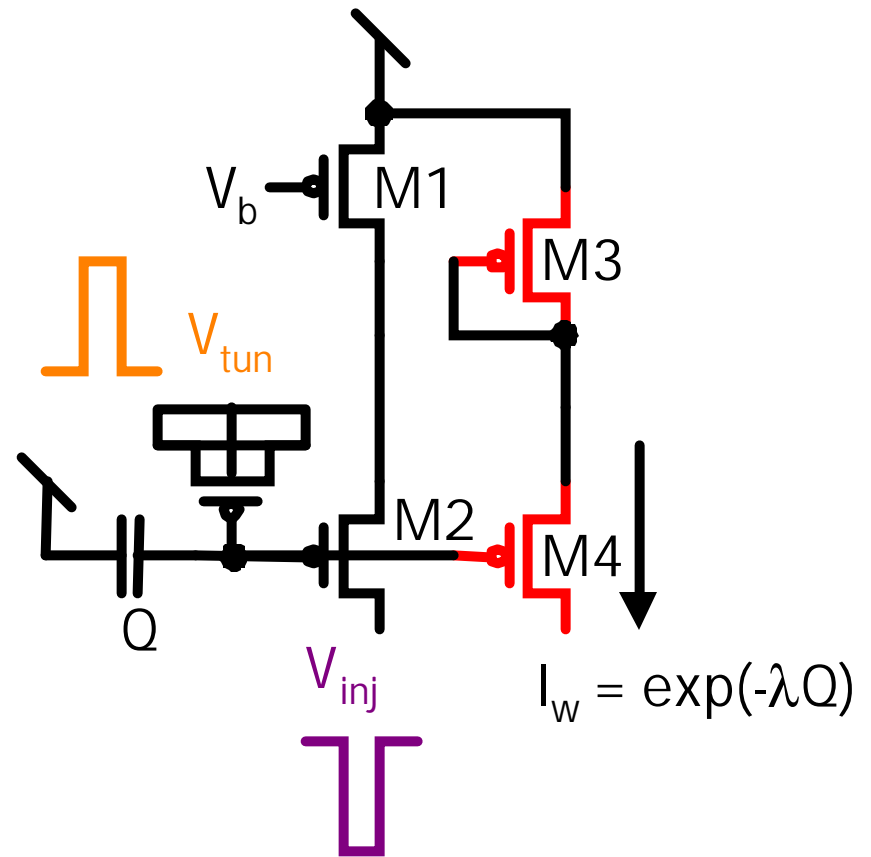


W as current: incremental updates

Store weight as current I_w
through M4

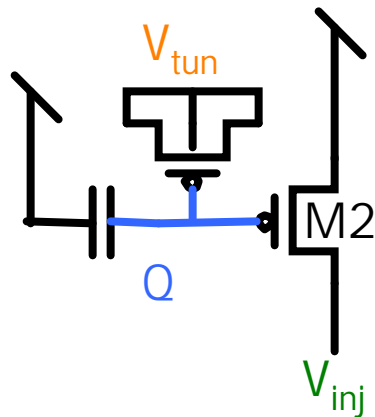
$$I_w = \exp(-I Q)$$

- Spike-based learning signals V_{tun} , V_{inj} signal presence or absence of discrete events
- Learning rule: update magnitude depends on previous weight



$$\left\langle \frac{dI_w}{dt} \right\rangle \propto I_w^{1-c} P(-V_{inj}) - I_w^{1+b} P(V_{tun})$$

Incremental Update

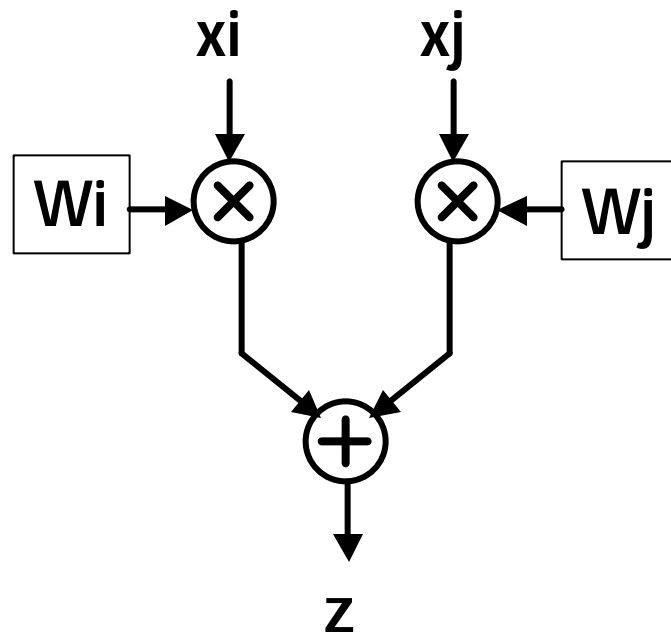


What we've seen so far:

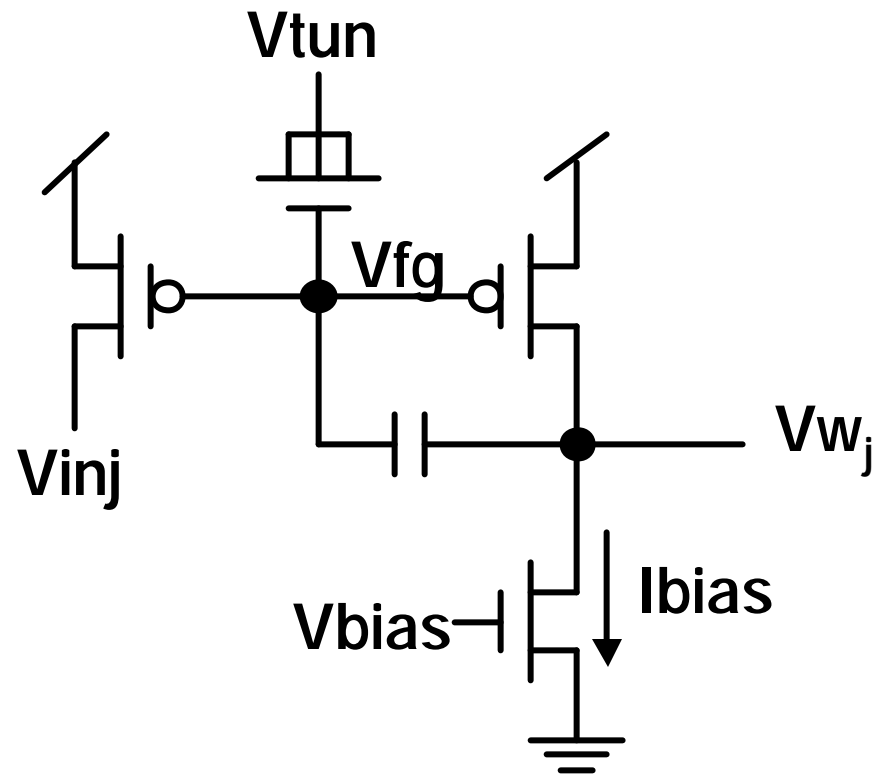
- Charge Q stored on FG, possibly encoding current through M2
- Tunneling and injection are exponential in V_{fg} ; thus current weight W affects the size of dW if we simply pulse V_{tun} or V_{inj}
- But some learning rules require size of update to be based only on input and error: $\Delta w_j = \alpha * x_j * err$

Weight-Independent Updates

- Feedback keeps V_{fg} constant, so a single pulse always has the same effect
- Weight stored as output voltage V_{w_j}

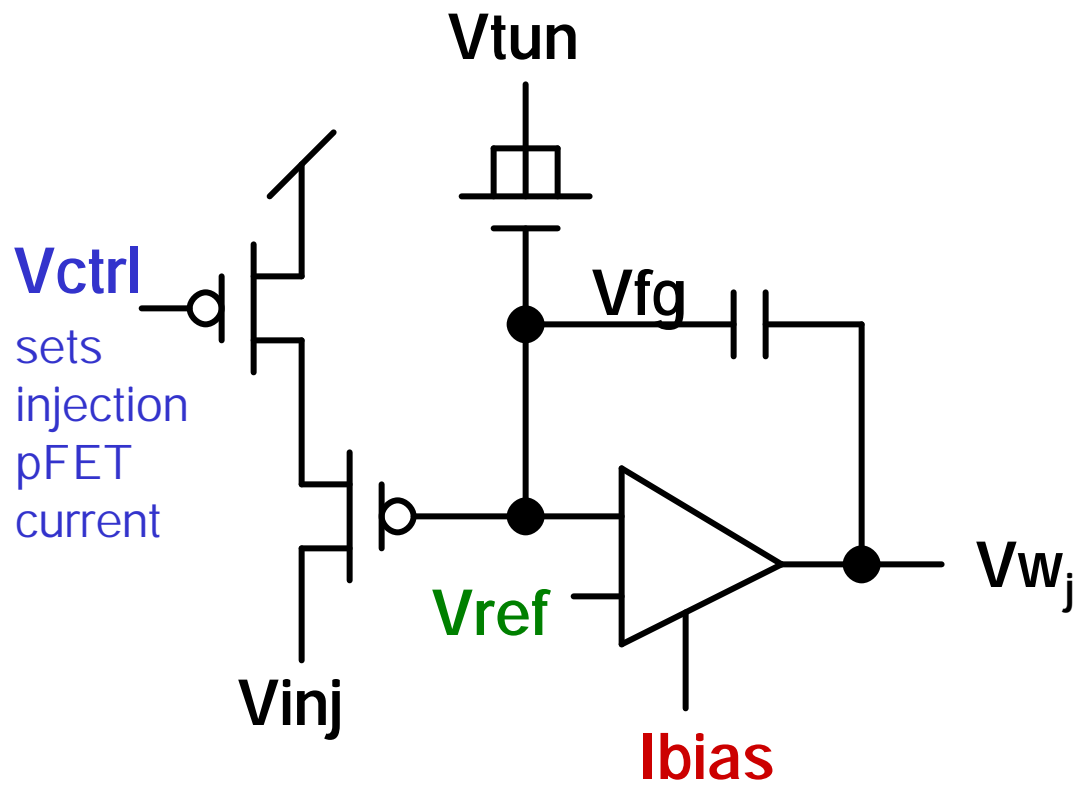


$$Dw_j = a * x_j * err$$



from Miguel Figueroa

Correcting matching of I_{TUN}/I_{INJ}



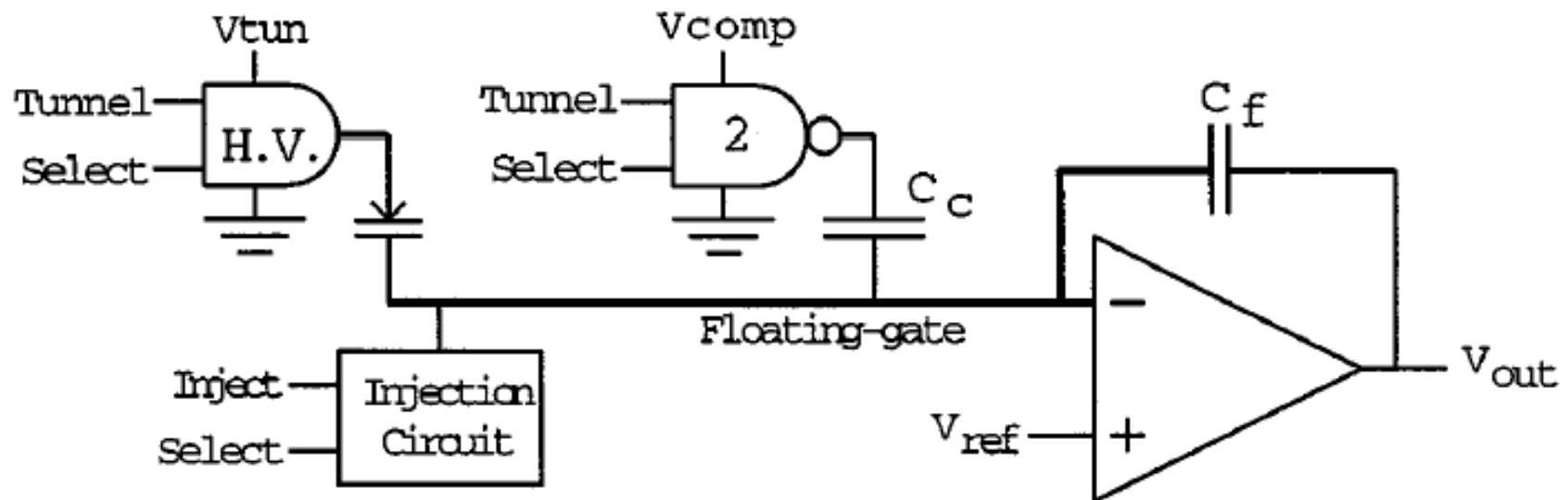
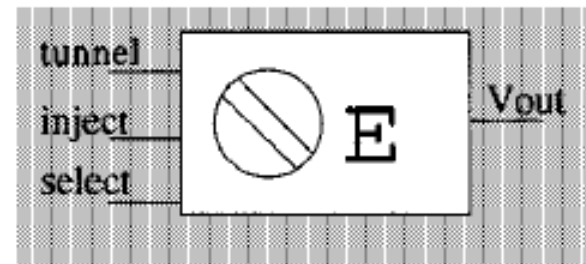
V_{ctrl}
sets
injection
pFET
current

V_{ref} sets V_{fg} ,
and adjusts
tunneling rate

allows amp speed
(current) to be
independent of V_{wj}

To make sure each I_{TUN} pulse deposits an equal amount of charge as one I_{INJ} pulse, we adjust inj and tun rate individually for each structure. A synapse transistor (not shown) can store value of V_{ctrl} and V_{ref} for each struct.

E-pots: long-term voltage storage



See Harrison, Bragg, Hasler, Minch, Deweerth, "A CMOS Programmable Analog Memory-Cell Array Using Floating-Gate Circuits", IEEE Trans. Circ. & Sys., Jan 2001

E-pot plots

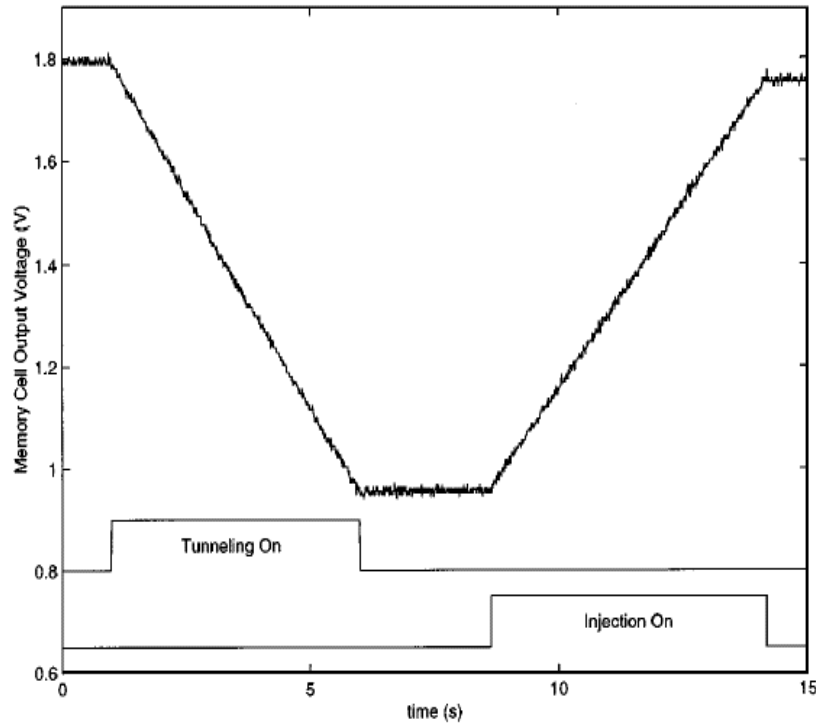


Fig. 3. Experimental measurement illustrating e-pot operation. Digital signals control tunneling and hot-electron injection, moving the e-pot output voltage up or down smoothly.

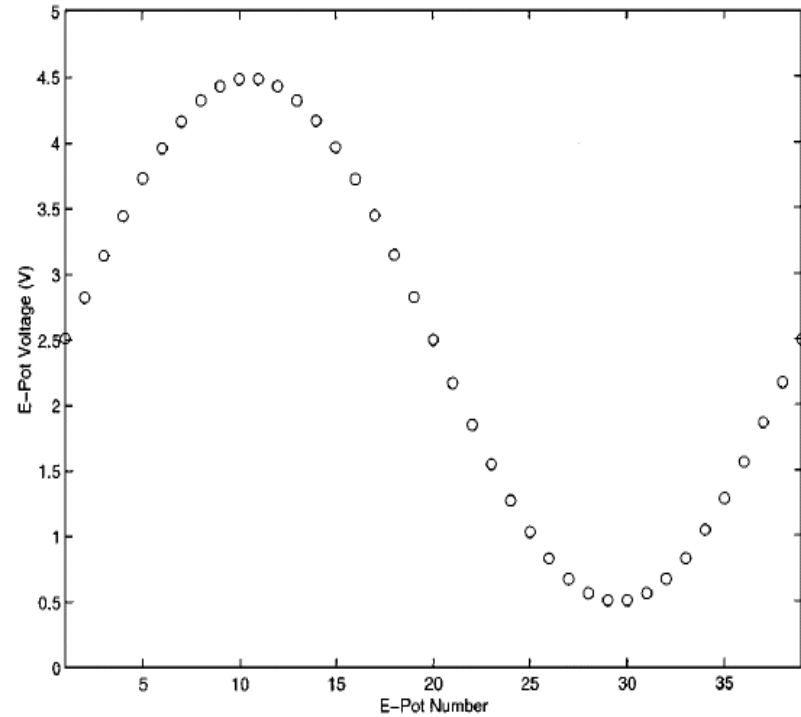


Fig. 4. Output voltages from all 39 e-pots from our 1.2- μm chip, after each element in the array had been programmed to a voltage proportional to the cosine of the e-pot position number. No crosstalk was observed between e-pot elements during programming.

See Harrison, Bragg, Hasler, Minch, Deweerth, “A CMOS Programmable Analog Memory-Cell Array Using Floating-Gate Circuits”, IEEE Trans. Circ. & Sys., Jan 2001

Summary thus far

- Store weight as charge (equilibrium reached when $I_{\text{TUN}}=I_{\text{INJ}}$)
- Store a copy of a current (with feedback)
- Increment weight using inj and tun spikes, and correcting mismatch between I_{TUN} & I_{INJ}
- Storing a copy of voltage
- Weight-independent updates (keep V_{FG} constant)

Final suggestion

- Use global tunneling as erase, and locally controlled injection to program
- Locally controlled tunneling requires either:
 - switching high voltages
 - local charge pumps (layout eats space)
 - Global tunneling requires only small tunneling junction at each FG